

***Interactive comment on “Comparison of SMILES
CIO profiles with other satellite and balloon-based
measurements” by H. Sagawa et al.***

H. Sagawa et al.

sagawa@nict.go.jp

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Please find attached PDF for our responses to the reviewer comments.

Please also note the supplement to this comment:

<http://www.atmos-meas-tech-discuss.net/6/C1843/2013/amtd-6-C1843-2013-supplement.pdf>

Interactive comment on Atmos. Meas. Tech. Discuss., 6, 613, 2013.